

<b>Notice of References Cited</b>	Application/Control No. 10/620,436	Applicant(s)/Patent Under Reexamination HIGUCHI ET AL.	
	Examiner TAN X. DINH	Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,493,561 a	02-1996	Nishiuchi et al.	369/275.1
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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